

TYA- Low Profile High Current SMT Power Inductor TYA252012 Series

FEATURES AND APPLICATIONS

Laird TYA series high current power inductors improve performance, reliability and power efficiency. A lower profile benefits consumer electronics, industrial and telecom design. Products feature extremely low DCR with greater efficiency and enable a large current in a small size. Inductors are of magnetic shielding and wire wound construction and perform in operating temperatures ranging from -40 C to 125 C including self-heating rise in temperature.

FEATURES

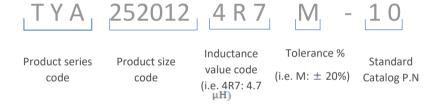
- Magnetic shielded structure
- · Low DCR and high efficiency
- Low profile and small size
- Metal alloy core with high saturation

APPLICATIONS

- DC-DC Converter and Power Suppliers
- LCD TV'S and Gaming Console
- Tablet, Notebooks, Servers and Printers
- Networking and Data storage
- GPS, Set-top-box and Base stations
- Smart meters and Medical instruments



PART NUMBER EXPLANATION



ELECTRICAL SPECIFICATIONS

- Tolerance: M: ±20% or N: ±30%
- Inductance tested at 1MHz, 1.0Vrms
- Heat Rated Current (Irms) is defined based on temperature rise approximate 40°C (ambient temperature 25±5°C)
- Saturation Current (Isat) is the DC current at which the inductance drops off approximately 30% from its value without current. (ambient temperature 25±5°C)
- Operating temperature range: -40°C~+125°C (including self-heating temperature rise)
- Storage temperature range (packaging conditions): -10°C~+40°C and RH 70%(MAX.)

Note: Heat Rated Current (Irms) is tested on a typical PCB and apply a constant current in still air. The temperature rise is dependent on the application system condition including PCB PAD pattern, trace width and thickness and adjacent components etc. It's suggested to verify the temperature rise of the component under the real operation application conditions.



Shielded Power Inductor

	www.laird.com	TYA252012 Series	Rev: A
SPECIFICATION			
1.MECHANICAL & DIMENSIONS			(UNIT: mm)
		А	2.50±0.30
B C	ļ	В	2.00±0.30
		- с	1.35 Max
		D	0.80±0.30
À	E	_ E	0.80±0.30
		- G	2.00 REF
	Я K □	Н	0.80 REF
<u> </u>	<u> </u>	- I	0.85 REF
2.PART NUMBER NOMENCLATOR: TYA 252012 6R8 M - 10 A B C D E A: Product Series. B: Series number, part size	E: "X"=0:Standard (rance. (M=±20%, N=±30 catalog part number ed customized part Or die than std catalog part.	%)
3.EQUIVALENT CIRCUIT:	3		



Shielded Power Inductor

PART NUMBER			WW\	w.laird.com 7	ΓΥΑ252012 Seri	es Rev: A
TYA252012R24M-10 0.24 4.05 6.50 23.0	SPECIFICATI	ON FOR A	PPROVAL			
TYA252012R33M-10	PART NUMBER		Irms(A) Typ.	Isat(A) Typ.	DCR(mΩ) Max	REMARK
TYA252012R47M-10 0.47 3.45 4.90 35.0 TYA252012R68M-10 0.68 3.15 3.80 45.0 TYA2520121R0M-10 1.00 3.00 3.60 54.0 TYA2520121R5M-10 1.50 2.40 2.90 78.0 TYA2520122R2M-10 2.20 1.90 2.60 120.0 TYA2520123R3M-10 3.30 1.50 1.70 215.0 TYA2520124R7M-10 4.70 1.25 1.60 260.0 TYA2520124R7M-10 6.80 0.95 1.20 366.0 TYA252012100M-10 10.00 0.85 1.10 480.0 TYA252012100M-10 10.00 0.85 1.10 480.0 SENERAL SPECIFICATION: 1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40°C to +125°C (Including self-heating) 3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 6, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	YA252012R24M-10	0.24	4.05	6.50	23.0	
TYA252012R68M-10	YA252012R33M-10	0.33	3.70	5.35	28.0	
TYA2520121R0M-10	YA252012R47M-10	0.47	3.45	4.90	35.0	
TYA2520121R5M-10	YA252012R68M-10	0.68	3.15	3.80	45.0	
TYA2520122R2M-10 2.20 1.90 2.60 120.0 TYA2520123R3M-10 3.30 1.50 1.70 215.0 TYA2520124R7M-10 4.70 1.25 1.60 260.0 TYA2520126R8M-10 6.80 0.95 1.20 366.0 TYA252012100M-10 10.00 0.85 1.10 480.0 SENERAL SPECIFICATION: 1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40 °C to +125 °C (Including self-heating) 3, Storage temperature: -10 °C to +40 °C 1, Humidity range: 70% RH Max. 3, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40 °C 3, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125 °C under worst case conditions.	YA2520121R0M-10	1.00	3.00	3.60	54.0	
TYA2520123R3M-10 3.30 1.50 1.70 215.0 TYA2520124R7M-10 4.70 1.25 1.60 260.0 TYA2520126R8M-10 6.80 0.95 1.20 366.0 TYA252012100M-10 10.00 0.85 1.10 480.0 SENERAL SPECIFICATION: 1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40 °C to +125 °C (Including self-heating) 3, Storage temperature: -10 °C to +40 °C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40 °C 6, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise) : Should not exceed 125 °C under worst case conditions.	YA2520121R5M-10	1.50	2.40	2.90	78.0	
TYA2520124R7M-10	YA2520122R2M-10	2.20	1.90	2.60	120.0	
TYA2520126R8M-10 6.80 0.95 1.20 366.0 TYA252012100M-10 10.00 0.85 1.10 480.0 GENERAL SPECIFICATION: 1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40°C to +125°C (Including self-heating) 3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 6, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise) : Should not exceed 125°C under worst case conditions.	YA2520123R3M-10	3.30	1.50	1.70	215.0	
TYA252012100M-10 10.00 0.85 1.10 480.0 GENERAL SPECIFICATION: 1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40°C to +125°C (Including self-heating) 3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 5, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise) : Should not exceed 125°C under worst case conditions.	YA2520124R7M-10	4.70	1.25	1.60	260.0	
GENERAL SPECIFICATION: 1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40°C to +125°C (Including self-heating) 3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 6, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	YA2520126R8M-10	6.80	0.95	1.20	366.0	
1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40°C to +125°C (Including self-heating) 3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 6, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	ΓYA252012100M-10	10.00	0.85	1.10	480.0	
1, Test conditions(L): 1.0MHz, 1Vrms 2, Operating temperature: -40°C to +125°C (Including self-heating) 3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 6, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise) : Should not exceed 125°C under worst case conditions.						
2, Operating temperature: -40°C to +125°C (Including self-heating) 3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 5, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	SENERAL SPECI	FICATION:			'	
3, Storage temperature: -10°C to +40°C 4, Humidity range: 70% RH Max. 5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 6, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	, Test conditions(L)	: 1.0MHz, 1Vrms				
I, Humidity range: 70% RH Max. I, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C I, Saturation Current (Isat) will cause L0 to drop approximately 30%. I, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	, Operating tempera	ature: -40°C to +12	25°C (Including self	-heating)		
5, Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C 5, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise) : Should not exceed 125°C under worst case conditions.	, Storage temperatu	ure: -10℃ to +40℃	C			
5, Saturation Current (Isat) will cause L0 to drop approximately 30%. 7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	, Humidity range: 70	0% RH Max.				
7, Part Temperature (Ambient+Temp. Rise): Should not exceed 125°C under worst case conditions.	, Heat Rated Currer	nt (Irms) will cause	e the coil temperate	ure rise approxim	nately ∆t of 40°C	
	, Saturation Current	t (Isat) will cause l	_0 to drop approxir	nately 30%.		
3. Storage condition (component in its packaging)	, Part Temperature	(Ambient+Temp.	Rise) : Should not	exceed 125°C u	nder worst case c	onditions.
, consige consistent (compensation by partiaging)	, Storage condition	(component in its	packaging)			

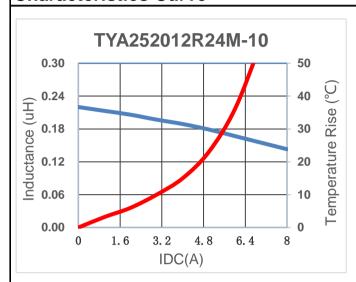


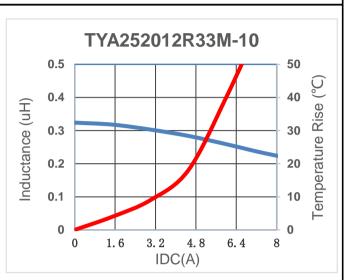
Shielded Power Inductor

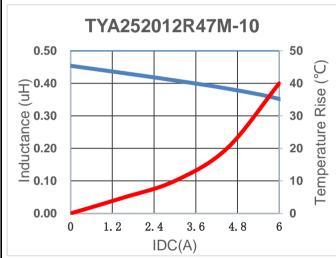
www.laird.com TYA252012 Series Rev: A

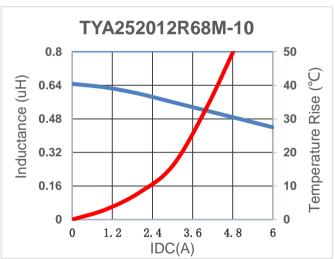
SPECIFICATION FOR APPROVAL

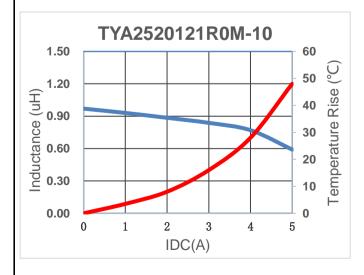
Characteristics Curve













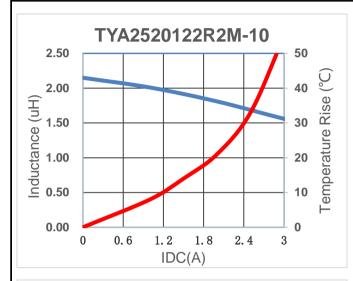


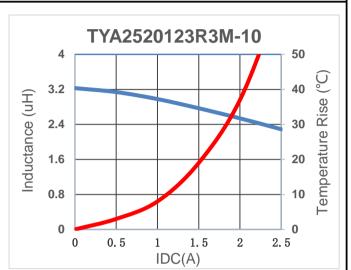
Shielded Power Inductor

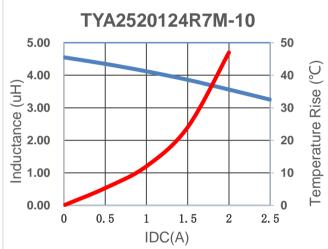
www.laird.com TYA252012 Series Rev: A

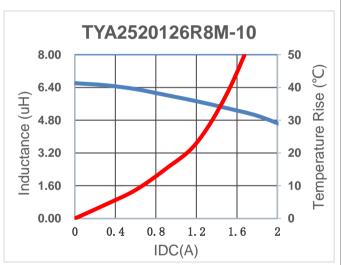
SPECIFICATION FOR APPROVAL

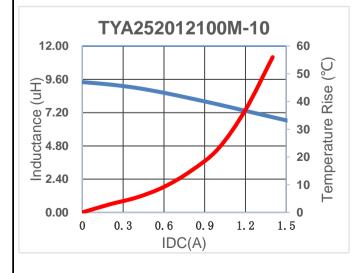
Characteristics Curve













Shielded Power Inductor

www.laird.com TYA252012 Series Rev: A

Recommended Soldering Conditions

For Lead-Free Application Figure 1 . Re-flow Soldering RECOMMENDED SOLDERING CONDITIONS TEMPERATURE ("C) ["F] 255°C MAX:255°C 240°C 200°C 190°C 20~40sec. Gradual Cooling 90±30sec 150°C



Shielded Power Inductor

www.laird.com TYA252012 Series Rev: A

Reliability and Testing Conditions / Pin Type Power Inductors

	SMD series(Consumer)					
Item	Specification	Test Method				
Operating temperature range	-40°C ~ +125°C (Including self-temperature rise)					
Storage temperature and humidity range	-10℃ to +40℃,70% RH Max					
High Temperature Exposure (Storage)	MIL-STD-202 Method 108	85±2℃, 168+24hours				
Temperature Cycling	JESD22 Method JA-104	-40°C →+85, transforming interval:20s, 100cycles				
Operational Life	MIL-PRF-2	85±℃, 168+24hours Apply maximum rated voltage and current according part drawing				
External Visual	MIL-STD-883 Method 2009	Inspect device construction, marking and workmanship. Electrical Test not required.				
Physical Dimension	JESD22 Method JB-100	Verify physical dimensions to the applicable device detail specification. Note: User(s) and Suppliers spec. Electrical Test not required				
Vibration	MIL-STD-202 Method 204	10~55Hz,1.5mm, 2 hours in each 3mutually perpendicular directions (total of 6 hours)				
Resistance to Soldering Heat	MIL-STD-202 Method 210	1. Max. 260±5°C,10±1s, 2 times 2.Solder Composition: Sn/3Ag/0.5Cu				
Solderability	J-STD-002	245±5℃, 5±1sec, Solder: Sn/3.0Ag/0.5Cu				
Electrical Characterization	Print Spec	Parametrically test per lot and sample size requirements, summary to show Min, Max, Mean and Standard deviation at room as well as Min and Max Operating temperatures				
Board Flex	AEC-Q200-005	2mm,30±1s				
Terminal Strength(SMD)	AEC-Q200-006	10N, 5S, X,Y direct				

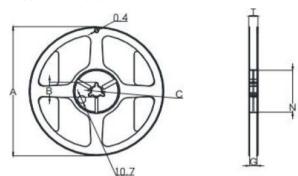


Shielded Power Inductor

TYA252012 Series Rev: A www.laird.com

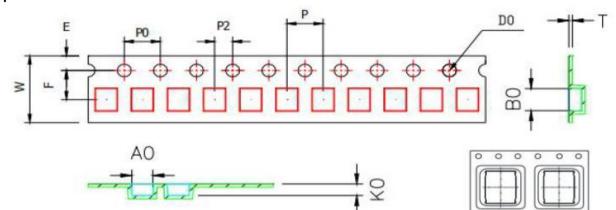
PACKAGING

Reel Dimension



TYPE	А	В	С	
	178	20.7±0.8	13±0.4	
8mm	G	N	T	
	9	60	10.8	

Tape Dimension

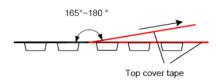


W	Е	F	Р	A0	В0	P2	P0	K0	t	D0
8.0±0.3	1.75±0.1	3.5±0.1	8±0.1	2.35±0.1	2.65±0.1	2.0±0.1	4.0±0.1	1.4±0.1	0.25±0.05	1.5Ref.

Packaging Quantity

P/N Chip/Reel		Inner Box	Outer Box
TYA252012 Series	2000pcs	10000pcs	50000pcs
Size		-	-

Peeling Off Force



The force	The force peeling off cove tape is 10 to 100 grams						
in the arrow direction under the following conditions							
Room	Room Humidity Room atrn Teaming Speed						
Temp	(%)	(hPa)	(mm/min)				
5~35	45~85	860~1060	300				

- **%Storage Conditions**1. Temperature and humidity conditions: -10-+40℃ and 70% RH.
- 2. Recommended products should be used within 12 months from the time of manufacturing.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.
- 4. Allowable stacking condition of Packaging box: max height 1.5m or 5 boxes stacking